





## **SOT-23 Formed SMD Package**

### **CMBT4401**

## SILICON PLANAR EPITAXIAL TRANSISTOR

N-P-N transistor

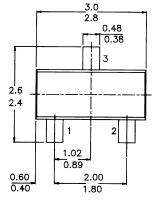
MarkingCMBT4401 = 2X

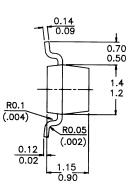
PACKAGE OUTLINE DETAILS
ALL DIMENSIONS IN mm



2 = EMITTER 3 = COLLECTOR







#### ABSOLUTE MAXIMUM RATINGS

Collector–emitter voltage	$V_{CEO}$	max.	40 V
Collector current (DC)	$I_C$	max.	600 mA
DC current gain			100
$I_C = 150 \ mA; \ V_{CE} = 1 \ V$	$h_{FE}$	min. max.	100 300
Total power dissipation up to $T_{amb} = 25$ °C	$P_{tot}$	max.	250 mW

# **RATINGS** (at $T_A = 25$ °C unless otherwise specified)

Limiting values Collector-emitter voltage 40 V  $V_{CEO}$ max. Collector-base voltage 60 V  $V_{CBO}$ max. Emitter-base voltage  $V_{EBO}$ max. 6 V Collector current (DC) max. 600 mA  $I_C$ Total power dissipation up to  $T_{amb} = 25$ °C  $P_{tot}$ 250 mW maxStorage temperature range  $T_{stg}$ -55 to +150 ° C  $T_i$ 150 ° C Junction temperature max.

## **CMBT4401**

THERMAL RESISTANCE From junction to ambient	R <sub>th j–a</sub>	=	500	K/W
CHARACTERISTICS				
$T_{amb} = 25$ °C unless otherwise specified				
Collector–emitter breakdown voltage				
$I_C = 1.0 \text{ mA}; I_B = 0$	$V_{(BR)CEO}$	>	40	V
Collector-base breakdown voltage	* *		60	* *
$I_C = 100 \mu A; I_E = 0$	$V_{(BR)CBO}$	>	60	V
Emitter-base breakdown voltage	17		6	V
$I_E = 100 \mu A; I_C = 0$ Base cut-off current	$V_{(BR)EBO}$	>	О	V
$V_{CE} = 35 \text{ V}; V_{EB} = 0.4 \text{ V}$	$I_{BEX}$	<	0.1	$\mu A$
Collector cut-off current	1BEX		0.1	μ21
$V_{CE} = 35 \text{ V}; V_{EB} = 0.4 \text{ V}$	$I_{CEX}$	<	0.1	$\mu A$
CL 35 17 VLB 311 V	-CLX	,	0.1	P12.2
D.C. current gain				
$I_C = 0.1 \text{ mA}; V_{CE} = 1 \text{ V}$	$h_{FE}$	>	20	
$I_C = 1.0 \ mA; \ V_{CE} = 1 \ V$	$h_{FE}$	>	40	
$I_C = 10 \ mA; \ V_{CE} = 1 \ V$	$h_{FE}$	>	80	
$I_C = 150 \ mA; \ V_{CE} = 1 \ V$	$h_{FE}$	100 to	300	
$I_C = 500 \ mA; \ V_{CE} = 2 \ V$	$h_{FE}$	>	40	
Saturation voltage				
$I_C = 150 \text{ mA}; I_B = 15 \text{ mA}$	V <sub>CEsat</sub>	<	0.4	
	$V_{BEsat}$	0.75 to	0.95	V
$I_C = 500 \ mA; I_B = 50 \ mA$	$V_{CEsat}$	<	0.75	V
	$V_{BEsat}$	<	1.2	V
T				
Transition frequency	C		250	
$f = 100 \text{ MHz}; I_C = 20 \text{ mA}; V_{CE} = 10 \text{ V}$	$f_T$	>	250	MHz
Collector-base capacitance	<i>C</i> .		0	nГ
$I_E = 0$ ; $V_{CB} = 5$ $V$ ; $f = 100$ $kHz$ Emitter—base capacitance	$C_{cb}$	<	0	рF
$I_C = 0$ ; $V_{BE} = 0.5 \text{ V}$ ; $f = 100 \text{ kHz}$	$C_{eh}$	<	30	рF
Input impedance; $f = 1 \text{ kHz}$ ;	Ceb		30	PΓ
	1.	min.	1	$k\Omega$
$I_C = 1 mA; V_{CE} = 10 V$	h <sub>ie</sub>	max.	8	$k\Omega$
Voltage feed-back ratio		_	1	
$I_C = 1 \text{ mA}; V_{CE} = 10 \text{ V}; f = 1 \text{ kHz}$	$h_{re}$	min. 0.1 ×		
,		max. 30 ×	$10^{-4}$	
Small-signal curent gain; $f = 1 \text{ kHz}$ ;				
$I_C = 1 mA; V_{CE} = 10 V$	$h_{fe}$	min.	40	
		max.	500	

Output admittance; $f = 1 \text{ kHz}$ ; $I_C = 1 \text{ mA}$ ; $V_{CE} = 10 \text{ V}$	h <sub>oe</sub>	min. max.	1 30	μS μG
Switching times (resistive load)				
Turn-on time				
$I_C = 150 \ mA; \ I_{B1} = 15 \ mA;$				
$V_{CC} = 30 \ V; \ V_{EB} = 2 \ V$				
delay time	$t_d$	max.	15	ns
rise time	$t_r$	max.	20 ns	
Turn-off time				
$I_C = 150 \text{ mA}; V_{CC} = 30 \text{ V};$				
$I_{B1} = I_{B2} = 15 \ mA$				
storage time	$t_S$	max.	225 ns	
fall time	$t_f$	max.	30 ns	

#### Disclaimer

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